

CUSTOMER:	DATE:	2023/08/07
CUSTOMER.	DAIE.	

APPROVAL SPECIFICATION

PRODUCT NAME:	SMD high current power inductor
YOUR PART NO.:	
OUR PART NO.:	MGHC966410E Series
VERSION: V1.0	

RECEPTION					
THE SPECIFICATION HAS BEEN ACCEPTED.					
COMPANY:					

MANUFACTURING NAME

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CATALOG

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Rev.	Effective Date	Changed Contents	Change Reasons	Approved By
1.0	2023/08/07	New released	/	Remo



1. Scope

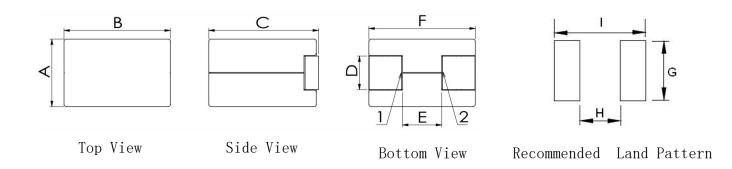
This specification applies to the MGHC966410E series of SMD power inductor.

2. Product Identification

<u>MGHC</u> <u>966410E</u> - <u>R12</u> <u>K</u> - <u>LF</u> (1) (2) (3) (4) (5)

- ① Product Symbol (High current SMD power inductor)
- 2 Product dimensions
- ③ Inductance Value: (R12: 120nH; R22: 220nH;)
- 4 Inductance Tolerance: (K: $\pm 10\%$; L: $\pm 15\%$; M: $\pm 20\%$;)
- (5) Lead free product.

3. Appearance and Dimensions



Dimensions in mm								
A	В	С	D	Е	F	G	Н	I
6.40 Max	9.60 Max	10.0 Max	2.60 Typ	3.80 Typ	9.10 Typ	3.10 Typ	3.40 Typ	9.90 Typ

Soldering surfaces to be coplanar within 0.10mm.

PCB tolerance ± 0.10 mm unless otherwise specified.

4. Testing Conditions



Unless otherwise specified, the standard conditions for measurement/test as:

Ambient Temperature : 5 to 35 ℃ Relative Humidity: 25 to 85% RH Atmospheric Pressure: 86 to 106 kPa

If any doubt on the results, measurements/tests should be made within the following limits:

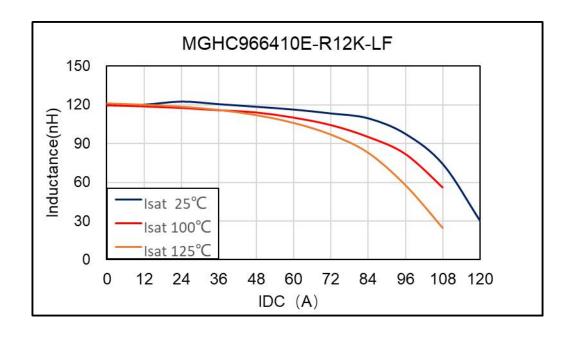
Ambient Temperature : 25±1°C Relative Humidity: 60 to 70% RH Atmospheric Pressure: 86 to 106 kPa

5. Electrical Characteristics

Microgate Part No.	Customer Part No.	Inductance (nH)	DCR ^{•1} (mΩ)	Isat ^{•2} @25°C (A)	Isat* ³ @100°C (A)	Isat* ⁴ @125°C (A)	Irms ^{•5} (A)
MGHC966410E-R12K-LF	-	120±10%	0.150±10%	98	83	73	67

^{*} Operating temperature:-40~+125°C (Including coils temperature rise)

Inductance Characteristics:



^{*} L test condition:100kHz & 1V at 25°C ambient;

^{* *1:} DCR: The nominal DCR is measured from point "1" to point "2" as seen in bottom view of Appearance and Dimensions.

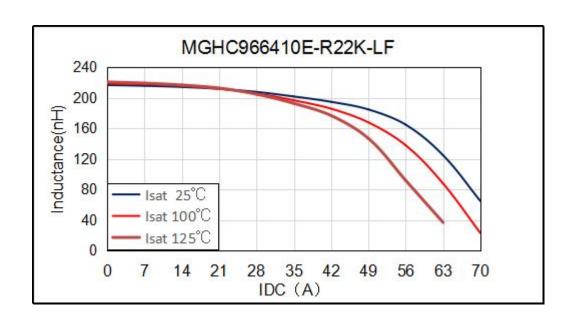
^{*2:}Isat@25°C: direct current at which the inductance drops approximate 30% from its value without current at 25°C;

^{•3:}Isat@100°C: direct current at which the inductance drops approximate 30% from its value without current at 100°C;

^{•4:}Isat@125°C: direct current at which the inductance drops approximate 30% from its value without current at 125°C;

^{*5:}Irms: direct current when the temperature of the product rise ($\triangle T = 40$ °C) from 20°C ambient.





6. Reliability and Test Condition

7. N o.	Item	Requirements	Test Methods and Remarks	Reference	Sample Size	
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No.	Item	Requirements	Test Methods and Remarks	Reference	Sample Size				
5	Loading at High Temperature		①Samples shall be from the Pre-conditioning group. ②Temperature: 85±2°C. ③Time: 1000 hours. ④Applied Current: Rated current. ⑤Measurement at 24±4 hours after test conclusion.	MIL-STD-202 Method 108 Test Condition D	77				
4	Board Flex		Support Solder Chip Printed circuit board before testing 45±2 45±2 Probe to exert bending force Radius 340 Printed circuit board under test Unit: mm	AEC-Q200 (AEC-Q200-005)	10				
		(1)No mechanical damage. (2)No corrosion. (3)Inductance value and DC resistance meet specifications.	①Part mounted on a 100mm*40mm FR4 PCB board, which is 1.6±0.2 mm thick and as a Layer-thickness 35 μm ± 10 μm. ②Bending speed is 1mm/s. ③Keeping the P.C Board 2 mm minimum for 60 seconds.						
3	Low Temperature Storage		②Time: 1000 hours. ③Measurement at 24±4 hours after test conclusion. Temp Low temperature -55°C Room Temp. 0 1000H Time	GB/T 2423.1-2008	77				
2	High Temperature Storage						①Temperature: 155±2°C. ②Time: 1000 hours. ③Measurement at 24±4 hours after test conclusion. Tempa High temperature 125°C Room Temp. 24H 0 1000H Time ①Temperature: -55°C.	AEC-Q200 (MIL-STD -202 Method 108)	77
1	Solderability	(1)No mechanical damage. (2)No corrosion (3)Terminal area must have 90% min. solder coverage.	①all samples shall be subjected to steam aging for a period of 8 hours as a precondition to testing ②Temperature:245±5°C, flux 5-10 s. ③Sample immersion tin furnace 5±1s. ④Immersed and in and out of speed: 25±6mm/s.	AEC-Q200 (J-STD-002)	40				



				基	43%
6	Resistance to Soldering Heat		①The peak temperature: 260+5/-0°C. ②Reflow:2 times. ③Temperature curve is as below: 265°C Peak 265°C Max. Ramp Up Rate=3°C/s 30 sec. min. Rate=-6°C/s 200°C	Reflow soldering: JEDED J-STD-020 Hand soldering: MIL-STD-202 Method 210 Section 4.4 Test condition A (table 1)	20
			1 reflow cycle + 1 hand soldering cycle		10
7	Pre- conditioning		2 reflow cycles	JESD22-A113	Sufficient for reliability test coverage
8	Temperature Cycling	(1)No mechanical damage. (2)No corrosion. (3)Inductance value and DC resistance meet specifications.	①Samples shall be from the Pre-conditioning group ②First -55°C for 30 minutes, last 155°C 30minutes as 1 cycle. Go through 200 cycles. ③Max transfer time is 5 minutes. ④Measurement at 24±4 hours after test conclusion. 125°C 30 min. Ambient 30 min. Ambient 30 min. 30 min. 30 min. **Temperature** 30 min. (max.)	MIL-STD -202 Method 107 Test condition D	77
9	Humidity Resistance		①Samples shall be from the Pre-conditioning group. ②1000 hours, 85±2°C / 85±2% RH. ③Unpowered. ④Measurement at 24±4 hours after test conclusion. Temple 85°C Room Temple 24H 0 1000H Time	AEC-Q200 (MIL-STD -202 Method 103)	77
10	Vibration		①Samples shall be from the Pre-conditioning group. ②10Hz to 55Hz at 15±1.5gs. ③Sweep time and duration: 10Hz~55Hz~10Hz for 20 minutes.	AEC-Q200 (MIL-STD-202 Method 204 Test condition B)	77



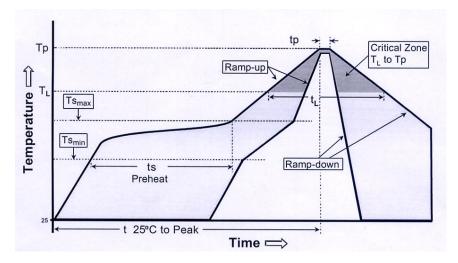
11	Terminal Strength	(1)No mechanical damage. (2)No corrosion. (3)Inductance value and DC resistance meet specifications.	①The test samples shall be soldered to the board. ②17.64N, 60s. Radium 1.5mm Press tool	AEC-Q200 (AEC-Q200-006)	10
			Substrate		

7. Recommended Soldering Conditions



(1) Reflow soldering conditions

Reflow curve



Profile Feature		Lead-Free Assembly	
Average Ramp-Up Rate (Ts max. to Tp)		3℃/second max.	
	- Temperature Min (Ts min.)	150 ℃	
Preheat	Temperature Max (Ts max.)	200 ℃	
	- Time (ts min to ts max.)	60-180 seconds	
Time maintained	- Temperature (TL)	217 °C	
above	- Time (tL)	60-150 seconds	
Peak/Classification Temperature (Tp)		260 ℃	
Peak/Classification Time (Tp)		3-4 seconds	
Time within 5 °C of actual Peak		20-40 seconds	
Temperature (Tp)			
Ramp-Down Rate		6°C/second max.	
Time 25 °C to Peak Temperature		8 minutes max.	

Note 1: All temperatures refer to topside of the package, measured on the package body surface.

(2) The method on Re-work with using the iron:

The following conditions must be strictly followed when using a soldering iron

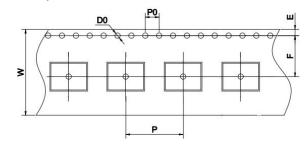
Pre-heating	150°C, 1 minute
Tip temperature	350°C max
Soldering iron output	80w max
End of soldering iron	φ1mm max
Soldering time	3 seconds max

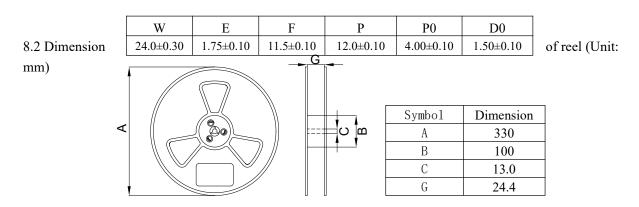
Product once removes from the circuit board may not be used again.

8. Package

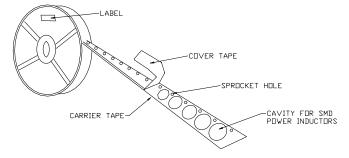


8.1 Dimension of tape (Unit: mm)





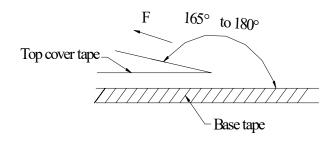
8.3 Taping figure and drawing direction



8.4 Packaging quantities: 500PCS/Reel.

8.5 Peeling strength of cover tape:

The peel force of top cover tape shall be between 0.1N to 1.3N



Room Temp.	Room Humidity	Room aim	Peel Speed
(℃)	(%)	(hpa)	Mm/min
5-35	45-85	860-1060	300

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9. Products Storage

(1) Storage period

Products which inspected in MICROGATE over 12 months ago should be examined and used, which can be confirmed with inspection No. marked on the container. Solderability should be checked if this period is exceeded.

(2) Storage conditions

Products should be storage in the warehouse on the following conditions:

Temperature: -10 ~+ 40°C

Humidity : Less than 80% relative and humidity

No rapid change on temperature and humidity

- (3) Don't keep products in corrosive gases such as sulfur, chlorine gas or acid, or it may cause oxidization of electrode, resulting in poor solderability.
- (4) Products should be storage on the palette for the prevention of the influence from humidity, dust and so on.
- (5) Products should be storage in the warehouse without heat shock, vibration, direct sunlight and so on.
- (6) Products should be storage under the airtight packaged condition.